

# 2SJ294

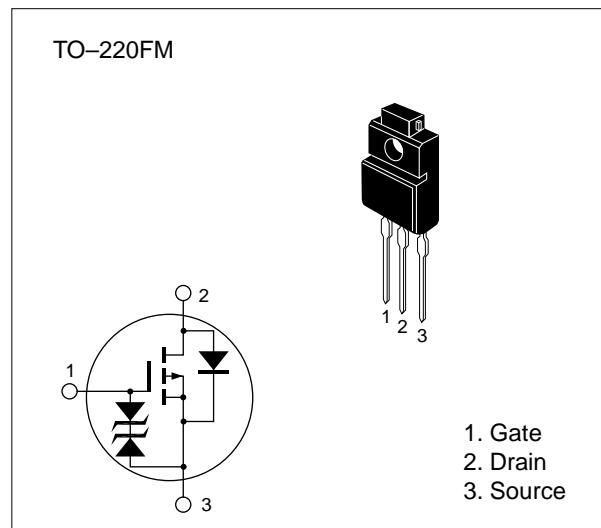
## Silicon P Channel MOS FET

### Application

High speed power switching

### Features

- Low on-resistance
- High speed switching
- Low drive current
- 4 V gate drive device can be driven from 5 V source
- Suitable for Switching regulator, DC – DC converter
- Avalanche Ratings



**Table 1 Absolute Maximum Ratings (Ta = 25°C)**

| Item                                   | Symbol                  | Ratings     | Unit |
|--|-------------------------|-------------|------|
| Drain to source voltage                | V <sub>DSS</sub>        | -60         | V    |
| Gate to source voltage                 | V <sub>GSS</sub>        | ±20         | V    |
| Drain current                          | I <sub>D</sub>          | -20         | A    |
| Drain peak current                     | I <sub>D(pulse)</sub> * | -80         | A    |
| Body-drain diode reverse drain current | I <sub>DR</sub>         | -20         | A    |
| Avalanche current                      | I <sub>AP</sub> ***     | -20         | A    |
| Avalanche energy                       | E <sub>AR</sub> ***     | 34          | mJ   |
| Channel dissipation                    | P <sub>ch</sub> **      | 35          | W    |
| Channel temperature                    | T <sub>ch</sub>         | 150         | °C   |
| Storage temperature                    | T <sub>stg</sub>        | -55 to +150 | °C   |

\* PW ≤ 10 µs, duty cycle ≤ 1 %

\*\* Value at T<sub>c</sub> = 25 °C

\*\*\* Value at T<sub>ch</sub> = 25 °C, R<sub>g</sub> ≥ 50 Ω

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**Table 2 Electrical Characteristics (Ta = 25°C)**

| Item                                       | Symbol               | Min  | Typ  | Max   | Unit | Test conditions  |
|--|----------------------|------|------|-------|------|--|
| Drain to source breakdown voltage          | V <sub>(BR)DSS</sub> | -60  | —    | —     | V    | I <sub>D</sub> = -10 mA, V <sub>GS</sub> = 0                         |
| Gate to source breakdown voltage           | V <sub>(BR)GSS</sub> | ±20  | —    | —     | V    | I <sub>G</sub> = ±100 µA, V <sub>DS</sub> = 0                        |
| Gate to source leak current                | I <sub>GSS</sub>     | —    | —    | ±10   | µA   | V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0                         |
| Zero gate voltage drain current            | I <sub>DSS</sub>     | —    | —    | -250  | µA   | V <sub>DS</sub> = -50 V, V <sub>GS</sub> = 0                         |
| Gate to source cutoff voltage              | V <sub>GS(off)</sub> | -1.0 | —    | -2.25 | V    | I <sub>D</sub> = -1 mA, V <sub>DS</sub> = -10 V                      |
| Static drain to source on state resistance | R <sub>DS(on)</sub>  | —    | 0.05 | 0.065 | Ω    | I <sub>D</sub> = -10 A<br>V <sub>GS</sub> = -10 V *                  |
|  |                      | —    | 0.07 | 0.095 | Ω    | I <sub>D</sub> = -10 A<br>V <sub>GS</sub> = -4 V *                   |
| Forward transfer admittance                | y <sub>fs</sub>      | 10   | 16   | —     | S    | I <sub>D</sub> = -10 A<br>V <sub>DS</sub> = -10 V *                  |
| Input capacitance                          | C <sub>iss</sub>     | —    | 2200 | —     | pF   | V <sub>DS</sub> = -10 V  |
| Output capacitance                         | C <sub>oss</sub>     | —    | 1000 | —     | pF   | V <sub>GS</sub> = 0  |
| Reverse transfer capacitance               | C <sub>rss</sub>     | —    | 300  | —     | pF   | f = 1 MHz  |
| Turn-on delay time                         | t <sub>d(on)</sub>   | —    | 25   | —     | ns   | I <sub>D</sub> = -10 A   |
| Rise time                                  | t <sub>r</sub>       | —    | 130  | —     | ns   | V <sub>GS</sub> = -10 V  |
| Turn-off delay time                        | t <sub>d(off)</sub>  | —    | 320  | —     | ns   | R <sub>L</sub> = 3 Ω   |
| Fall time                                  | t <sub>f</sub>       | —    | 210  | —     | ns   |  |
| Body-drain diode forward voltage           | V <sub>DF</sub>      | —    | -1.1 | —     | V    | I <sub>F</sub> = -20 A, V <sub>GS</sub> = 0                          |
| Body-drain diode reverse recovery time     | t <sub>rr</sub>      | —    | 160  | —     | ns   | I <sub>F</sub> = -20 A, V <sub>GS</sub> = 0,<br>diF / dt = 50 A / µs |

\* Pulse Test

See characteristic curves of 2SJ291

